

FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)			ATTY DOCKET NO. <b>35.C15514</b>		APPLICATION NO. <b>09/845,286</b>	
			APPLICANT <b>TADAYASU MEGURO ET AL.</b>			
			FILING DATE <b>May 1, 2001</b>			GROUP <b>2879</b>
			U.S. PATENT DOCUMENTS			
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
TSP	6,208,071	3/27/01	Nishimura et al.	313	495	
TSP	4,954,744	9/4/90	Suzuki et al.	313	336	
FOREIGN PATENT DOCUMENTS						
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES(No) OR ABSTRACT
TSP	EP 0850892	7/98	EPO			(In English)
TSP	10-241550	9/98	Japan			Abstract and USP 6208071
TSP	8-180801	7/96	Japan			Abstract
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)						
TSP	M.I. Ellinson et al., "The Emission of Hot Electrons and The Field Emission of Electrons From Tin Oxide", Radio Engineering and Electronic Physics, July 1965, pp. 1290-1296.					
	H. Araki, "Electroforming and Electron Emission of Carbon Thin Films", Journal of the Vacuum, Society of Japan, 1983, pp. 22-29 (with English-language abstract on page 22).					
	G. Dittmer, "Electrical Conduction and Electron Emission of Discontinuous Thin Films", Thin Solid Films, 9, 1972, pp. 317-328.					
	M. Hartwell, "Strong Electron Emission From Patterned Tin-Indium Oxide Thin Films", IEDM, 1975, pp. 519-521.					
	C.A. Spindt, "Physical Properties of Thin-Film Emission Cathodes with Molybdenum Cones", J. Applied Physics, Vol. 47, No. 12, December 1976, pp. 5248-5263.					
TSP	J. Dyke et al., "Field Emission", Advances in Electronics and Electron Physics, Vol. VIII, 1956, pp. 89-185.					
EXAMINER	THANH S. PHAN		DATE CONSIDERED	3/18/02		

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Sheet 1 of 1